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Applications of "<u>Embedded - Microcontrollers</u>"

Details	
Product Status	Active
Core Processor	S08
Core Size	8-Bit
Speed	20MHz
Connectivity	LINbus, SCI, UART/USART
Peripherals	LVD, POR, PWM
Number of I/O	18
Program Memory Size	4KB (4K x 8)
Program Memory Type	FLASH
EEPROM Size	128 x 8
RAM Size	512 x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 5.5V
Data Converters	A/D 8x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	20-TSSOP (0.173", 4.40mm Width)
Supplier Device Package	20-TSSOP
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mc9s08pl4ctj

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1 Ordering information

The following table summarizes the part numbers of the devices covered by this document.

Table 1. Ordering information

Part Number	MC9S08PL4CTJ	MC9S08PL4CTG	MC9S08PL4CSC
Max. frequency (MHz)	20	20	20
Flash memory (KB)	4	4	4
RAM (bytes)	512	512	512
EEPROM (bytes)	128	128	128
10-bit ADC	8ch	8ch	4ch
16-bit FlexTimer	2ch + 2ch	2ch + 2ch	2ch + 1ch
RTC	Yes	Yes	Yes
SCI (LIN Capable)	1	1	1
Watchdog	Yes	Yes	Yes
KBI pins	8	8	4
GPIO	18	14	6
Package	20-TSSOP	16-TSSOP	8-SOIC

2 Part identification

2.1 Description

Part numbers for the chip have fields that identify the specific part. You can use the values of these fields to determine the specific part you have received.

2.2 Format

Part numbers for this device have the following format:

MC 9 S08 PL AA B CC

2.3 Fields

This table lists the possible values for each field in the part number (not all combinations are valid):

Field	Description	Values
MC	Qualification status	MC = fully qualified, general market flow
9	Memory	9 = flash based
S08	Core	• S08 = 8-bit CPU
PL	Device family	• PL
AA	Approximate flash size in KB	• 4 = 4 KB
В	Operating temperature range (°C)	• C = -40 to 85
CC	Package designator	 TJ = 20-TSSOP TG = 16-TSSOP SC = 8-SOIC

2.4 Example

This is an example part number:

MC9S08PL4CTJ

3 Parameter Classification

The electrical parameters shown in this supplement are guaranteed by various methods. To give the customer a better understanding, the following classification is used and the parameters are tagged accordingly in the tables where appropriate:

Table 2. Parameter Classifications

Р	Those parameters are guaranteed during production testing on each individual device.
С	Those parameters are achieved by the design characterization by measuring a statistically relevant sample size across process variations.
Т	Those parameters are achieved by design characterization on a small sample size from typical devices under typical conditions unless otherwise noted. All values shown in the typical column are within this category.
D	Those parameters are derived mainly from simulations.

NOTE

The classification is shown in the column labeled "C" in the parameter tables where appropriate.

General

This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (for instance, either V_{SS} or V_{DD}) or the programmable pullup resistor associated with the pin is enabled.

Symbol	Description	Min.	Max.	Unit
V _{DD}	Supply voltage	-0.3	6.0	V
I _{DD}	Maximum current into V _{DD}	_	120	mA
V _{DIO}	Digital input voltage (except $\overline{\text{RESET}}$, EXTAL, XTAL, or true open drain pin)	-0.3	V _{DD} + 0.3	V
	Digital input voltage (true open drain pin)	-0.3	6	V
V _{AIO}	Analog ¹ , RESET, EXTAL, and XTAL input voltage	-0.3	V _{DD} + 0.3	V
I _D	Instantaneous maximum current single pin limit (applies to all port pins)	- 25	25	mA
V_{DDA}	Analog supply voltage	V _{DD} – 0.3	V _{DD} + 0.3	V

All digital I/O pins, except open-drain pin, are internally clamped to V_{SS} and V_{DD}. is only clamped to V_{SS}.

5 General

5.1 Nonswitching electrical specifications

5.1.1 DC characteristics

This section includes information about power supply requirements and I/O pin characteristics.

Symbol C **Descriptions** Min Unit Typical¹ Max 2.7 Operating voltage 5.5 V_{OH} С Output high All I/O pins, standard-5 V, $I_{load} =$ $V_{DD} - 0.8$ ٧ voltage drive strength -5 mA С 3 V, $I_{load} =$ $V_{DD} - 0.8$ V -2.5 mA D Output high Max total I_{OH} for all 5 V -100 mΑ IOHT current ports 3 V -50 ٧ V_{OL} С Output low 5 V, $I_{load} = 5$ 8.0 All I/O pins, standardvoltage drive strength

Table 3. DC characteristics

Table continues on the next page...

Table 3. DC characteristics (continued)

Symbol	С		Descriptions		Min	Typical ¹	Max	Unit
	С			3 V, I _{load} = 2.5 mA	_	_	0.8	V
I _{OLT}	D	Output low	Max total I _{OL} for all	5 V	_	_	100	mA
		current	ports	3 V	_	_	50	
V _{IH}	Р	Input high	All digital inputs	V _{DD} >4.5V	$0.70 \times V_{DD}$	_	_	V
	С	voltage		V _{DD} >2.7V	$0.75 \times V_{DD}$	_	_	
V _{IL}	Р	Input low	All digital inputs	V _{DD} >4.5V	_	_	$0.30 \times V_{DD}$	V
	С	voltage		V _{DD} >2.7V	_	_	$0.35 \times V_{DD}$	
V_{hys}	С	Input hysteresis	All digital inputs	_	$0.06 \times V_{DD}$	_	_	mV
II _{In} I	Р	Input leakage current	All input only pins (per pin)	$V_{IN} = V_{DD}$ or V_{SS}	_	0.1	1	μA
II _{OZ} I	Р	Hi-Z (off- state) leakage current	All input/output (per pin)	$V_{IN} = V_{DD}$ or V_{SS}	_	0.1	1	μA
I _{OZTOT}	С	Total leakage combined for all inputs and Hi-Z pins	All input only and I/O	$V_{IN} = V_{DD}$ or V_{SS}	_	_	2	μА
R _{PU}	Р	Pullup resistors	All digital inputs, when enabled (all I/O pins other than PTB0)	_	30.0	_	50.0	kΩ
R _{PU} ²	Р	Pullup resistors	PTB0 pin	_	30.0	_	60.0	kΩ
I _{IC}	D	DC injection	Single pin limit	$V_{IN} < V_{SS}$	-0.2	_	2	mA
		current ^{3, 4, 5}	Total MCU limit, includes sum of all stressed pins	$V_{IN} > V_{DD}$	-5	_	25	
C _{In}	С	Input cap	acitance, all pins	_	_	_	7	pF
V_{RAM}	С	RAM re	etention voltage	_	2.0	_	_	V

- 1. Typical values are measured at 25 °C. Characterized, not tested.
- 2. The specified resistor value is the actual value internal to the device. The pullup value may appear higher when measured externally on the pin.
- 3. All functional non-supply pins, except for PTB0, are internally clamped to V_{SS} and V_{DD} .
- 4. Input must be current-limited to the value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive and negative clamp voltages, then use the large one.
- 5. Power supply must maintain regulation within operating V_{DD} range during instantaneous and operating maximum current conditions. If the positive injection current (V_{In} > V_{DD}) is higher than I_{DD}, the injection current may flow out of V_{DD} and could result in external power supply going out of regulation. Ensure that external V_{DD} load will shunt current higher than maximum injection current when the MCU is not consuming power, such as no system clock is present, or clock rate is very low (which would reduce overall power consumption).

Table 4. LVD and POR Specification

Symbol	С	Description	Min	Тур	Max	Unit
V _{POR}	D	POR re-arm voltage ^{1, 2}	1.5	1.75	2.0	V

Table continues on the next page...

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Nonswitching electrical specifications

Table 4. LVD and POR Specification (continued)

Symbol	С	Descr	iption	Min	Тур	Max	Unit
V _{LVDH}	С	threshold - high	Falling low-voltage detect threshold - high range (LVDV = 1) ³		4.3	4.4	V
V _{LVW1H}	С	Falling low- voltage	Level 1 falling (LVWV = 00)	4.3	4.4	4.5	V
V _{LVW2H}	С	warning threshold - high range	Level 2 falling (LVWV = 01)	4.5	4.5	4.6	V
V _{LVW3H}	С	riigir rarige	Level 3 falling (LVWV = 10)	4.6	4.6	4.7	V
V _{LVW4H}	С		Level 4 falling (LVWV = 11)	4.7	4.7	4.8	V
V _{HYSH}	С		High range low-voltage detect/warning hysteresis		100	_	mV
V _{LVDL}	С	threshold - low i	Falling low-voltage detect threshold - low range (LVDV = 0)		2.61	2.66	V
V _{LVDW1L}	С	Falling low- voltage	Level 1 falling (LVWV = 00)	2.62	2.7	2.78	V
V _{LVDW2L}	С	warning threshold - low range	Level 2 falling (LVWV = 01)	2.72	2.8	2.88	V
V _{LVDW3L}	С	low range	Level 3 falling (LVWV = 10)	2.82	2.9	2.98	V
V _{LVDW4L}	С		Level 4 falling (LVWV = 11)	2.92	3.0	3.08	V
V _{HYSDL}	С		Low range low-voltage detect hysteresis		40	_	mV
V _{HYSWL}	С		Low range low-voltage warning hysteresis		80	_	mV
V _{BG}	Р	Buffered band	dgap output 4	1.14	1.16	1.18	V

^{1.} Maximum is highest voltage that POR is guaranteed.

^{2.} POR ramp time must be longer than 20us/V to get a stable startup.

^{3.} Rising thresholds are falling threshold + hysteresis.

^{4.} Voltage factory trimmed at V_{DD} = 5.0 V, Temp = 25 °C

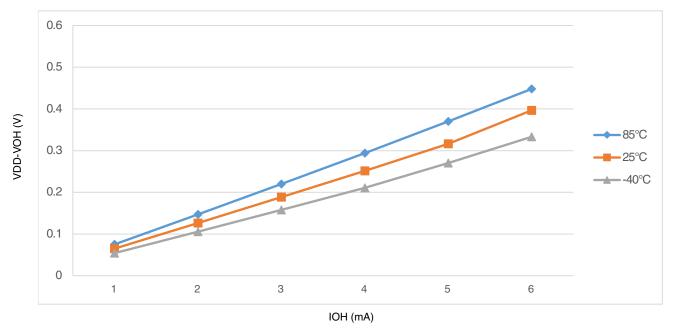


Figure 1. Typical I_{OH} Vs. V_{DD} - V_{OH} (standard drive strength) (V_{DD} = 5 V)

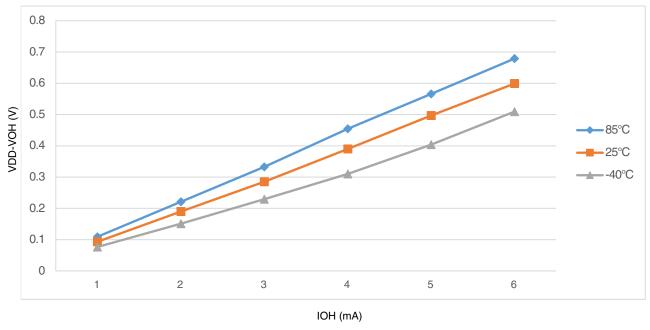


Figure 2. Typical I_{OH} Vs. V_{DD} - V_{OH} (standard drive strength) (V_{DD} = 3 V)

Nonswitching electrical specifications

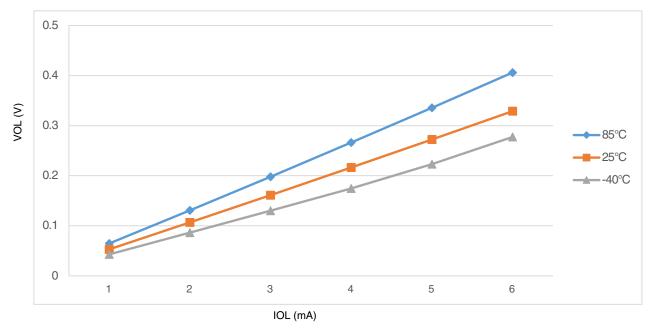


Figure 3. Typical I_{OL} Vs. V_{OL} (standard drive strength) ($V_{DD} = 5 \text{ V}$)

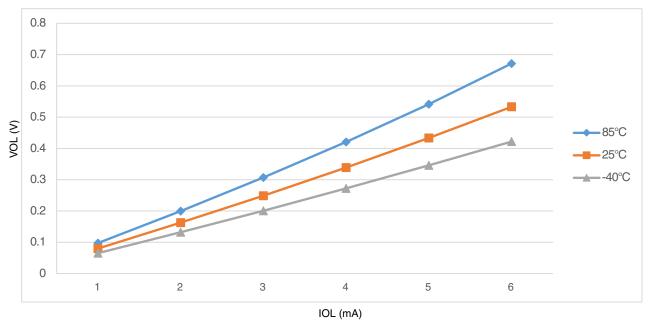


Figure 4. Typical I_{OL} Vs. V_{OL} (standard drive strength) ($V_{DD} = 3 \text{ V}$)

Num	С	Rating	Symbol	Min	Typical ¹	Max	Unit	
8	D	Keyboard interrupt pulse width	Asynchronous path ²	t _{ILIH}	100	_	_	ns
	D		Synchronous path	t _{IHIL}	$1.5 \times t_{cyc}$	_	_	ns
9	С	Port rise and fall time -	_	t _{Rise}	_	10.2	_	ns
	С	standard drive strength (load = 50 pF) ⁵		t _{Fall}	_	9.5	_	ns

- 1. Typical values are based on characterization data at V_{DD} = 5.0 V, 25 °C unless otherwise stated.
- 2. This is the shortest pulse that is guaranteed to be recognized as a reset pin request.
- To enter BDM mode following a POR, BKGD/MS must be held low during the powerup and for a hold time of t_{MSH} after V_{DD} rises above V_{LVD}.
- 4. This is the minimum pulse width that is guaranteed to pass through the pin synchronization circuitry. Shorter pulses may or may not be recognized. In stop mode, the synchronizer is bypassed so shorter pulses can be recognized.
- 5. Timing is shown with respect to 20% V_{DD} and 80% V_{DD} levels in operating temperature range.

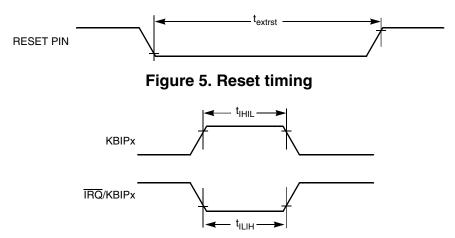


Figure 6. IRQ/KBIPx timing

5.2.2 Debug trace timing specifications

Table 7. Debug trace operating behaviors

Symbol	Description	Min.	Max.	Unit
t _{cyc}	Clock period	Frequency	dependent	MHz
t _{wl}	Low pulse width	2	_	ns
t _{wh}	High pulse width	2	_	ns
t _r	Clock and data rise time	_	3	ns
t _f	Clock and data fall time	_	3	ns
t _s	Data setup	3	_	ns
t _h	Data hold	2	_	ns

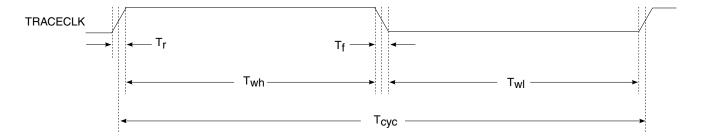


Figure 7. TRACE_CLKOUT specifications

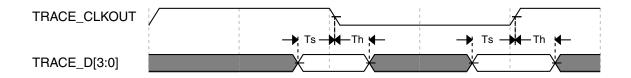


Figure 8. Trace data specifications

5.2.3 FTM module timing

Synchronizer circuits determine the shortest input pulses that can be recognized or the fastest clock that can be used as the optional external source to the timer counter. These synchronizers operate from the current bus rate clock.

No.	С	Function	Function Symbol		Max	Unit
1	D	External clock frequency	f _{TCLK}	0	f _{Bus} /4	Hz
2	D	External clock period	TOLK		_	t _{cyc}
3	D	External clock high time	t _{clkh}	1.5	_	t _{cyc}
4	D	External clock low time	t _{clkl}	1.5	_	t _{cyc}
5	D	Input capture pulse width	t _{ICPW}	1.5	_	t _{cyc}

Table 8. FTM input timing

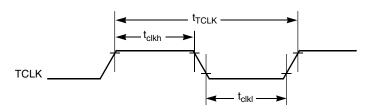


Figure 9. Timer external clock

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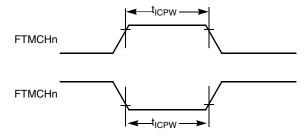


Figure 10. Timer input capture pulse

5.3 Thermal specifications

5.3.1 Thermal characteristics

This section provides information about operating temperature range, power dissipation, and package thermal resistance. Power dissipation on I/O pins is usually small compared to the power dissipation in on-chip logic and voltage regulator circuits, and it is user-determined rather than being controlled by the MCU design. To take $P_{I/O}$ into account in power calculations, determine the difference between actual pin voltage and V_{SS} or V_{DD} and multiply by the pin current for each I/O pin. Except in cases of unusually high pin current (heavy loads), the difference between pin voltage and V_{SS} or V_{DD} will be very small.

Rating **Symbol** Value Unit °C Operating temperature T_A^1 T_L to T_H -40 to 85 range (packaged) °C Junction temperature T_{J} -40 to 105 range Thermal resistance single-layer board 20-pin TSSOP 115 °C/W $R_{\theta JA}$ 16-pin TSSOP $R_{\theta JA}$ 130 °C/W 8-pin SOIC $R_{\theta JA}$ 150 °C/W Thermal resistance four-layer board 20-pin TSSOP °C/W $R_{\theta JA}$ 16-pin TSSOP $R_{\theta JA}$ 87 °C/W 8-pin SOIC 87 °C/W $R_{\theta JA}$

Table 9. Thermal characteristics

^{1.} Maximum T_A can be exceeded only if the user ensures that T_J does not exceed the maximum. The simplest method to determine T_J is: $T_J = T_A + R_{\theta JA} x$ chip power dissipation.

6 Peripheral operating requirements and behaviors

6.1 External oscillator (XOSC) and ICS characteristics

Table 10. XOSC and ICS specifications in operating temperature range

Num	С	Characteristic		Symbol	Min	Typical ¹	Max	Unit
1	С	Oscillator	Low range (RANGE = 0)	f _{lo}	31.25	32.768	39.0625	kHz
	С	crystal or resonator	High range (RANGE = 1) FEE or FBE mode ²	f _{hi}	4	_	20	MHz
	С		High range (RANGE = 1), high gain (HGO = 1), FBELP mode	f _{hi}	4	_	20	MHz
	С		High range (RANGE = 1), low power (HGO = 0), FBELP mode	f _{hi}	4	_	20	MHz
2	D	Lo	oad capacitors	C1, C2		See Note ³		
3	D	Feedback resistor	Low Frequency, Low-Power Mode ⁴	R_{F}	_	_	_	ΜΩ
			Low Frequency, High-Gain Mode		_	10	_	ΜΩ
			High Frequency, Low- Power Mode		_	1	_	ΜΩ
			High Frequency, High-Gain Mode		_	1	_	ΜΩ
4	D	Series resistor -	Low-Power Mode ⁴	R _S	_	_	_	kΩ
		Low Frequency	High-Gain Mode		_	200	_	kΩ
5	D	Series resistor - High Frequency	Low-Power Mode ⁴	R_S	_	_	_	kΩ
	D	Series resistor -	4 MHz		_	0	_	kΩ
	D	High Frequency,	8 MHz		_	0	_	kΩ
	D	High-Gain Mode	16 MHz		_	0	_	kΩ
6	С	Crystal start-up	Low range, low power	t _{CSTL}	_	1000	_	ms
	С	time Low range = 32.768 kHz	Low range, high power		_	800	_	ms
	С	crystal; High	High range, low power	t _{CSTH}	_	3	_	ms
	С	range = 20 MHz crystal ⁵ , ⁶) MHz High range, high power		_	1.5	_	ms
7	Т	Internal re	eference start-up time	t _{IRST}	_	20	50	μs
8	D	Square wave	FEE or FBE mode ²	f _{extal}	0.03125	_	5	MHz
	D	input clock frequency	FBELP mode		0	_	20	MHz
9	Р	Average internal reference frequency - trimmed		f _{int_t}	_	31.25	_	kHz
10	Р	DCO output fi	equency range - trimmed	f _{dco_t}	16	_	20	MHz

Table continues on the next page...

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Table 10. XOSC and ICS specifications in operating temperature range (continued)

Num	С	Characteristic		Symbol	Min	Typical ¹	Max	Unit
11	Р	Total deviation of DCO output	Over full voltage and temperature range	Δf_{dco_t}	_	_	±2.0	%f _{dco}
	С	from trimmed frequency ⁵	Over fixed voltage and temperature range of 0 to 70 °C				±1.0	
12	С	FLL a	FLL acquisition time ⁵ , ⁷		_	_	2	ms
13	С		tter of DCO output clock d over 2 ms interval) ⁸	C _{Jitter}	_	0.02	0.2	%f _{dco}

- 1. Data in Typical column was characterized at 5.0 V, 25 °C or is typical recommended value.
- 2. When ICS is configured for FEE or FBE mode, input clock source must be divisible using RDIV to within the range of 31.25 kHz to 39.0625 kHz.
- 3. See crystal or resonator manufacturer's recommendation.
- Load capacitors (C₁,C₂), feedback resistor (R_F) and series resistor (R_S) are incorporated internally when RANGE = HGO =
- 5. This parameter is characterized and not tested on each device.
- 6. Proper PC board layout procedures must be followed to achieve specifications.
- 7. This specification applies to any time the FLL reference source or reference divider is changed, trim value changed, or changing from FLL disabled (FBELP, FBILP) to FLL enabled (FEI, FEE, FBE, FBI). If a crystal/resonator is being used as the reference, this specification assumes it is already running.
- 8. Jitter is the average deviation from the programmed frequency measured over the specified interval at maximum f_{Bus}. Measurements are made with the device powered by filtered supplies and clocked by a stable external clock signal. Noise injected into the FLL circuitry via V_{DD} and V_{SS} and variation in crystal oscillator frequency increase the C_{Jitter} percentage for a given interval.

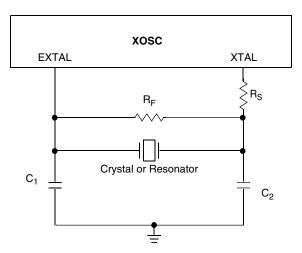


Figure 11. Typical crystal or resonator circuit

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6.2 NVM specifications

This section provides details about program/erase times and program/erase endurance for the flash and EEPROM memories.

Table 11. Flash characteristics

С	Characteristic	Symbol	Min ¹	Typical ²	Max ³	Unit ⁴
D	Supply voltage for program/erase -40 °C to 85 °C	V _{prog/erase}	2.7	_	5.5	V
D	Supply voltage for read operation	V _{Read}	2.7	_	5.5	V
D	NVM Bus frequency	f _{NVMBUS}	1	_	25	MHz
D	NVM Operating frequency	f _{NVMOP}	0.8	1	1.05	MHz
D	Erase Verify All Blocks	t _{VFYALL}	_	_	17338	t _{cyc}
D	Erase Verify Flash Block	t _{RD1BLK}	_	_	16913	t _{cyc}
D	Erase Verify EEPROM Block	t _{RD1BLK}	_	_	810	t _{cyc}
D	Erase Verify Flash Section	t _{RD1SEC}	_	_	484	t _{cyc}
D	Erase Verify EEPROM Section	t _{DRD1SEC}	_	_	555	t _{cyc}
D	Read Once	t _{RDONCE}	_	_	450	t _{cyc}
D	Program Flash (2 word)	t _{PGM2}	0.12	0.12	0.29	ms
D	Program Flash (4 word)	t _{PGM4}	0.20	0.21	0.46	ms
D	Program Once	t _{PGMONCE}	0.20	0.21	0.21	ms
D	Program EEPROM (1 Byte)	t _{DPGM1}	0.10	0.10	0.27	ms
D	Program EEPROM (2 Byte)	t _{DPGM2}	0.17	0.18	0.43	ms
D	Program EEPROM (3 Byte)	t _{DPGM3}	0.25	0.26	0.60	ms
D	Program EEPROM (4 Byte)	t _{DPGM4}	0.32	0.33	0.77	ms
D	Erase All Blocks	t _{ERSALL}	96.01	100.78	101.49	ms
D	Erase Flash Block	t _{ERSBLK}	95.98	100.75	101.44	ms
D	Erase Flash Sector	t _{ERSPG}	19.10	20.05	20.08	ms
D	Erase EEPROM Sector	t _{DERSPG}	4.81	5.05	20.57	ms
D	Unsecure Flash	t _{UNSECU}	96.01	100.78	101.48	ms
D	Verify Backdoor Access Key	t _{VFYKEY}	_	_	464	t _{cyc}
D	Set User Margin Level	t _{MLOADU}	_	_	407	t _{cyc}
С	FLASH Program/erase endurance T _L to T _H = -40 °C to 85 °C	n _{FLPE}	10 k	100 k	_	Cycles
С	EEPROM Program/erase endurance TL to TH = -40 °C to 85 °C	n _{FLPE}	50 k	500 k	_	Cycles
С	Data retention at an average junction temperature of T _{Javg} = 85°C after up to 10,000 program/erase cycles	t _{D_ret}	15	100	_	years

^{1.} Minimum times are based on maximum $f_{\mbox{\scriptsize NVMOP}}$ and maximum $f_{\mbox{\scriptsize NVMBUS}}$

^{2.} Typical times are based on typical f_{NVMOP} and maximum f_{NVMBUS}

^{3.} Maximum times are based on typical f_{NVMOP} and typical f_{NVMBUS} plus aging

^{4.} $t_{cyc} = 1 / f_{NVMBUS}$

Program and erase operations do not require any special power sources other than the normal V_{DD} supply. For more detailed information about program/erase operations, see the Memory section.

6.3 Analog

6.3.1 **ADC** characteristics

Table 12. 5 V 10-bit ADC operating conditions

Characteri stic	Conditions	Symb	Min	Typ ¹	Max	Unit	Comment
Supply	Absolute	V _{DDA}	2.7	_	5.5	V	_
voltage	Delta to V _{DD} (V _{DD} -V _{DDAD})	ΔV_{DDA}	-100	0	+100	mV	
Ground voltage	Delta to V _{SS} (V _{SS} -V _{SSA}) ²	ΔV_{SSA}	-100	0	+100	mV	
Input voltage		V _{ADIN}	V _{REFL}	_	V _{REFH}	V	
Input capacitance		C _{ADIN}	_	4.5	5.5	pF	
Input resistance		R _{ADIN}	_	3	5	kΩ	_
Analog source	10-bit mode • f _{ADCK} > 4 MHz	R _{AS}	_	_	5	kΩ	External to MCU
resistance	• f _{ADCK} < 4 MHz		_	_	10		
	8-bit mode		_	_	10		
	(all valid f _{ADCK})						
ADC	High speed (ADLPC=0)	f _{ADCK}	0.4	_	8.0	MHz	_
conversion clock frequency	Low power (ADLPC=1)		0.4	_	4.0		

^{1.} Typical values assume $V_{DDA} = 5.0 \text{ V}$, Temp = 25°C, $f_{ADCK} = 1.0 \text{ MHz}$ unless otherwise stated. Typical values are for reference only and are not tested in production.

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^{2.} DC potential difference.

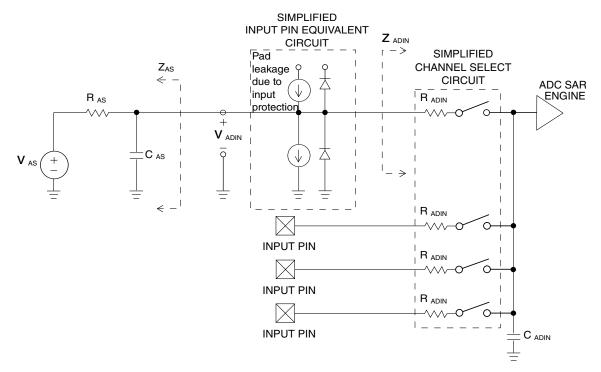


Figure 12. ADC input impedance equivalency diagram

Table 13. 10-bit ADC Characteristics ($V_{REFH} = V_{DDA}$, $V_{REFL} = V_{SSA}$)

Characteristic	Conditions	С	Symb	Min	Typ ¹	Max	Unit
Supply current		T	I _{DDA}	_	133	_	μΑ
ADLPC = 1							
ADLSMP = 1							
ADCO = 1							
Supply current		Т	I _{DDA}	_	218	_	μΑ
ADLPC = 1							
ADLSMP = 0							
ADCO = 1							
Supply current		Т	I _{DDA}	_	327	_	μΑ
ADLPC = 0							
ADLSMP = 1							
ADCO = 1							
Supply current		Т	I _{DDAD}	_	582	990	μΑ
ADLPC = 0							
ADLSMP = 0							
ADCO = 1							
Supply current	Stop, reset, module off	Т	I _{DDA}	_	0.011	1	μА
ADC asynchronous clock source	High speed (ADLPC = 0)	Р	f _{ADACK}	2	3.3	5	MHz

Table continues on the next page...

Table 13. 10-bit ADC Characteristics ($V_{REFH} = V_{DDA}$, $V_{REFL} = V_{SSA}$) (continued)

Characteristic	Conditions	С	Symb	Min	Typ ¹	Max	Unit
	Low power (ADLPC = 1)			1.25	2	3.3	
Conversion time (including sample	Short sample (ADLSMP = 0)	Т	t _{ADC}	_	20	_	ADCK cycles
time)	Long sample (ADLSMP = 1)			_	40	_	
Sample time	Short sample (ADLSMP = 0)	Т	t _{ADS}	_	3.5	_	ADCK cycles
	Long sample (ADLSMP = 1)			_	23.5	_	
Total unadjusted	10-bit mode	Р	E _{TUE}	_	±1.5	±2.0	LSB ³
Error ²	8-bit mode	Р		_	±0.7	±1.0	
Differential Non-	10-bit mode ⁴	Р	DNL	_	±0.25	±0.5	LSB ³
Linearity	8-bit mode ⁴	Р		_	±0.15	±0.25	
Integral Non-Linearity	10-bit mode	Т	INL	_	±0.3	±0.5	LSB ³
	8-bit mode	Т		_	±0.15	±0.25	
Zero-scale error ⁵	10-bit mode	Р	E _{ZS}	_	±0.25	±1.0	LSB ³
	8-bit mode	Р		_	±0.65	±1.0	
Full-scale error ⁶	10-bit mode	Т	E _{FS}	_	±0.5	±1.0	LSB ³
	8-bit mode	Т		_	±0.5	±1.0	
Quantization error	≤10 bit modes	D	EQ	_	_	±0.5	LSB ³
Input leakage error ⁷	all modes	D	E _{IL}		I _{In} * R _{AS}	!	mV
Temp sensor slope	-40°C– 25°C	D	m	_	3.266	_	mV/°C
	25°C– 85°C			_	3.638	_	
Temp sensor voltage	25°C	D	V _{TEMP25}	_	1.396	_	V

^{1.} Typical values assume $V_{DDA} = 5.0 \text{ V}$, Temp = 25°C, $f_{ADCK} = 1.0 \text{ MHz}$ unless otherwise stated. Typical values are for reference only and are not tested in production.

7 Dimensions

7.1 Obtaining package dimensions

Package dimensions are provided in package drawings.

^{2.} Includes quantization.

^{3.} $1 LSB = (V_{REFH} - V_{REFL})/2^N$

^{4.} Monotonicity and no-missing-codes guaranteed in 10-bit and 8-bit modes

^{5.} $V_{ADIN} = V_{SSA}$

^{6.} $V_{ADIN} = V_{DDA}$

^{7.} I_{In} = leakage current (refer to DC characteristics)

Pinout

To find a package drawing, go to nxp.com and perform a keyword search for the drawing's document number:

If you want the drawing for this package	Then use this document number
8-pin SOIC	98ASB42564B
16-pin TSSOP	98ASH70247A
20-pin TSSOP	98ASH70169A

8 Pinout

8.1 Signal multiplexing and pin assignments

The following table shows the signals available on each pin and the locations of these pins on the devices supported by this document. The Port Control Module is responsible for selecting which ALT functionality is available on each pin.

Table 14. Pin availability by package pin-count

Pin Number			Lowest Priority <> Highest						
20-TSSOP	16-TSSOP	8-SOIC	Port Pin	Alt 1	Alt 2	Alt 3	Alt 4		
1	1	1	PTA5	IRQ	FTM1CH0	_	RESET		
2	2	2	PTA4	_	_	BKGD	MS		
3	3	3	_	_	_	_	V_{DD}		
4	4	4	_	_	_	_	V _{SS}		
5	5	_	PTB7	_	_	_	EXTAL		
6	6	_	PTB6	_	_	_	XTAL		
7	7	_	PTB5	_	FTM1CH1	_	_		
8	8	_	PTB4	_	FTM1CH0	_	_		
9	_	_	PTC3	_	_	_	_		
10	_	_	PTC2	_	_	_	_		
11	_	_	PTC1	_	_	_	_		
12	_	_	PTC0	_	_	_	_		
13	9	_	PTB3	KBI0P7	_	TCLK1	ADP7		
14	10	_	PTB2	KBI0P6	_	_	ADP6		
15	11	_	PTB1	KBI0P5	TxD0	_	ADP5		
16	12	_	PTB0 ¹	KBI0P4	RxD0	TCLK0	ADP4		
17	13	5	PTA3	KBI0P3	FTM0CH1	TxD0	ADP3		
18	14	6	PTA2	KBI0P2	FTM0CH0	RxD0	ADP2		
19	15	7	PTA1	KBI0P1	FTM0CH1	_	ADP1		
20	16	8	PTA0	KBI0P0	FTM0CH0	_	ADP0		

Revision history

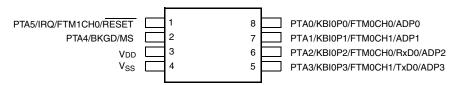


Figure 15. 8-pin SOIC packages

9 Revision history

The following table provides a revision history for this document.

Table 15. Revision history

Rev. No.	Date	Substantial Changes
0	03/2018	Initial Created
1	04/2018	Completed all the TBDs.

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